

<b>Notice of References Cited</b>	Application/Control No. 10/654,619	Applicant(s)/Patent Under Reexamination LEWIN ET AL.	
	Examiner Van Kim T. Nguyen	Art Unit 2152	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,061,357	05-2000	Olshansky et al.	370/401
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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